

Applicant: Yuichi Akage et al.

Confirmation No.: 5766

Serial No.: 10/576,627

Att'y Docket No.: 14321.83

Filing Date: April 21, 2006

Art Unit: 2873

For: ELECTRODE PAD ON CONDUCTIVE SEMICONDUCTOR SUBSTRATE

INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANTU.S. Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Issue Date</u>	<u>Name</u>
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Foreign Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Publication Date</u>	<u>Country or Patent Office</u>	<u>Translation</u>
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_____ 1	06-013438	01/21/1994	Japan	No
_____ 2	2003-023010	01/24/2003	Japan	No

Other Documents

(including author, title, pertinent pages, etc.)

<u>Examiner Initial*</u>

_____ 3	M.N. Khan et al., <i>Theoretical Prediction and Experimental Verification of Quantum Well Electroabsorption Modulators with Bandwidths Exceeding 40 GHz</i> , OFC99, paper ThT4-1/293.
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References Cited by Applicants

While the filing of Information Disclosure Statements is voluntary, the procedure is governed by the guidelines of Section 609 of the Manual of Patent Examining Procedure and 37 C.F.R. §§ 1.97 and 1.98. To be considered a proper Information Disclosure Statement, Form PTO-1449 shall be accompanied by a copy of each listed patent or publication or other item of information and a translation of the pertinent portions of foreign documents (if an existing translation is readily available to the applicant), an explanation of relevance of each reference not in the English language, and should be submitted in a timely manner as set out in MPEP Sec. 609.

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The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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